Se	arci	h No	otes	S	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/727,594	DELBREIL ET AL.
Examiner	Art Unit
JOHN J. LEE	2618

SEARCHED					
Class	Subclass	Date	Examiner		
455	403 561 562.11 67.11 509 11.9 19.1	12/22/2006	J.L		
709	224	12/22/2006	J.L		
		•			
			_		
			÷		

ERFERENCE	E SEARC	HED
Subclass	Date	Examiner
		*
	Subclass	Subclass Date

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	60/ دد عا	Jim		
•				
•				
	· .			